

Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at <u>www.onsemi.com</u>

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild_questions@onsemi.com.

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or unavteries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out or i, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor and is officers, employees, uniotificated use, even if such claim any manner.



FCP16N60 / FCPF16N60 N-Channel SuperFET[®] MOSFET 600 V, 16 A, 260 mΩ

Features

- 650V @ T_{.I} = 150°C
- Typ. R_{DS(on)} = 220 mΩ
- Ultra Low Gate Charge (Typ. Q_g = 55 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 110 pF)
- 100% Avalanche Tested

Applications

- Solar Inverter
- AC-DC Power Supply

August 2014

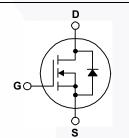
FCP16N60 / FCPF16N60 — N-Channel SuperFET[®] MOSFET

Description

SuperFET[®] MOSFET is Fairchild Semiconductor's first generation of high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low onresistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.







Absolute Maximum Ratings

Symbol		Parameter		FCP16N60	FCPF16N60	Unit	
V _{DSS}	Drain-Source Voltage			6	V		
ID	Drain Current	- Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		16 10.1	16* 10.1*	A A	
I _{DM}	Drain Current	- Pulsed	(Note 1)	48	48*	А	
V _{GSS}	Gate-Source Voltage			±	V		
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	450		mJ	
I _{AR}	Avalanche Current		(Note 1)	16		А	
E _{AR}	Repetitive Avalanche Energy		(Note 1)	20.8		mJ	
dv/dt	Peak Diode Recov	/ery dv/dt	(Note 3)	4.5		V/ns	
P _D	Power Dissipation	(T _C = 25°C) - Derate Above 25°C		167 1.33	37.9 0.3	W W/°C	
T _{J,} T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C		
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			3	°C		

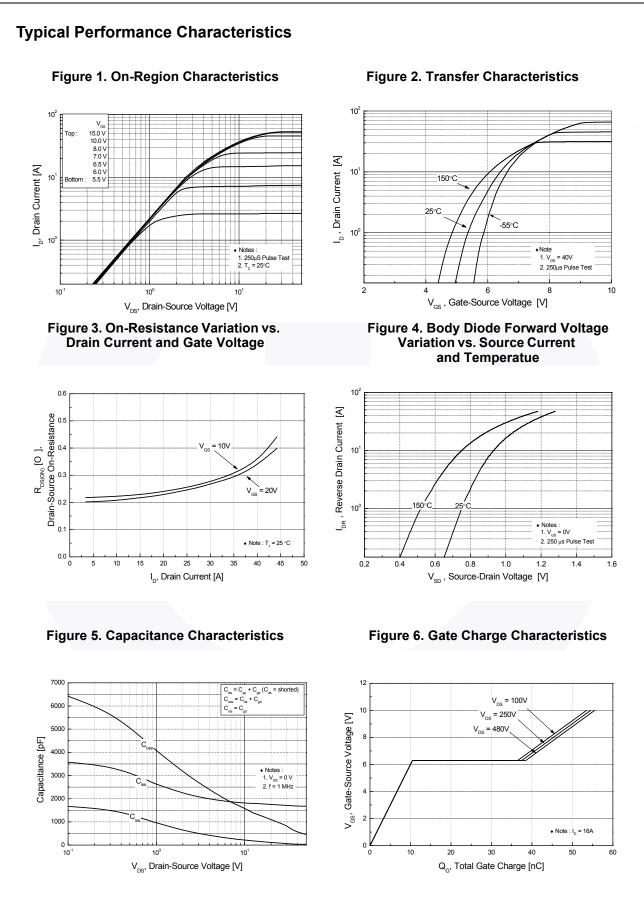
*Drain current limited by maximum junction temperature.

Thermal Characteristics

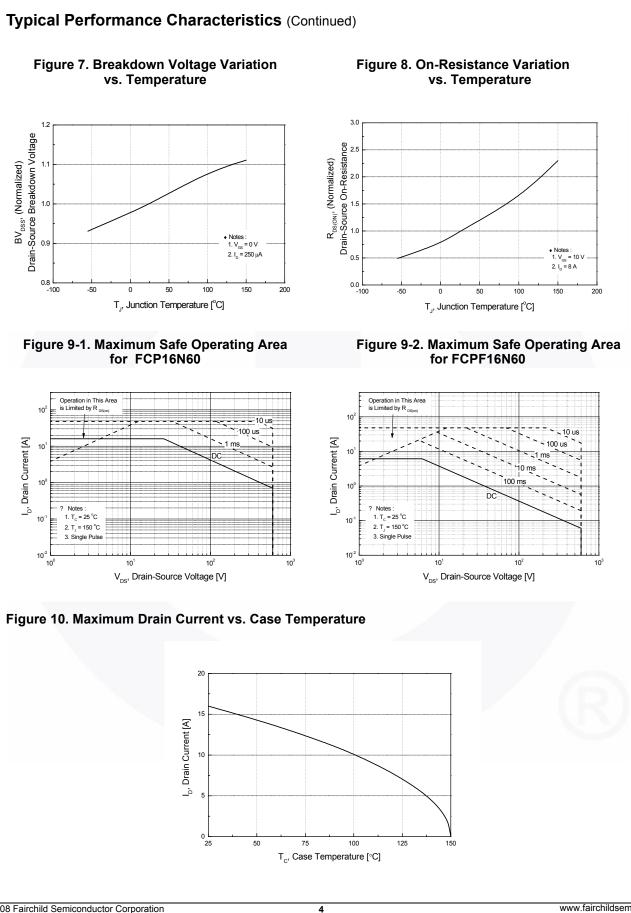
Symbol	Parameter	FCP16N60	FCPF16N60	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.75	3.3	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W

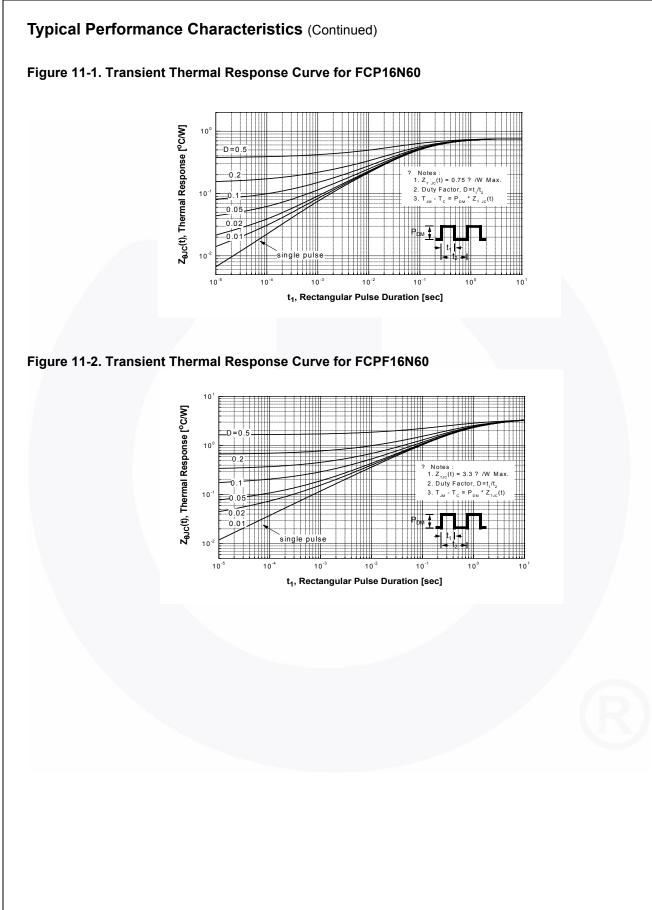
1

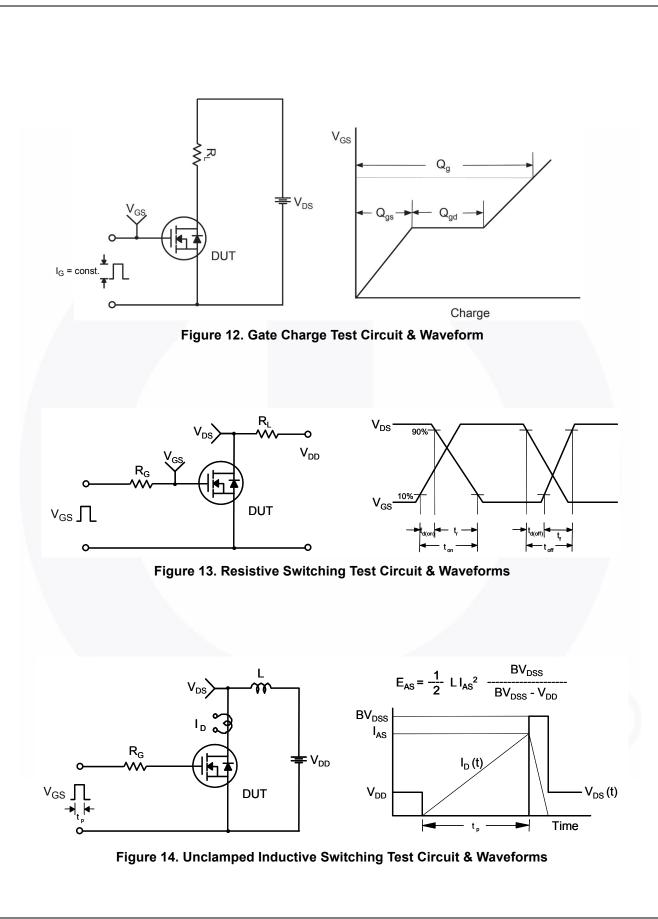
60		Package	Packing Method	Reel Size	Тар	e Width	Qua	ntity
	FCP16N60	TO-220	Tube	N/A		N/A	50 units	
FCPF16N60 FCPF16N60 TO			Tube	N/A		N/A	50 units	
Charac	cteristics T _C = 25	^o C unless	otherwise noted.					
	Parameter					Тур.	Max.	Unit
teristics							I	
			I _D = 250 μA. V _{CS} = 0 V.	T ₁ = 25 ^o C	600	-	_	V
Drain to Source Breakdown Voltage		10 An	$I_D = 250 \ \mu\text{A}, \ V_{GS} = 0 \ V, \ T_J = 150^{\circ}\text{C}$			650	-	V
Breakdown Voltage Temperature Coefficient			$I_D = 250 \ \mu$ A, Referenced to 25° C			0.6	-	V/ºC
Drain-Source Avalanche Breakdown Voltage			V _{GS} = 0 V, I _D = 16 A			700	-	v
S Zero Gate Voltage Drain Cur		V _{DS} = 600 V, V _{GS} = 0 V		-	-	1		
			V _{DS} = 480 V, T _C = 125 ^o C		-	-	10	μA
Gate to Body Leakage Current			V_{GS} = ±30 V, V_{DS} = 0 V	,	-	-	±100	nA
teristics								
Gate Threshold Voltage			$V_{CS} = V_{DS}$. $I_{D} = 250 \mu A$			-	5.0	V
Static Drain to Source On Resistance						0.55	0.26	Ω
Forward Transconductance						11.5	-	S
haracteri	stics			I. I.		1	1	
1					-	1730	2250	pF
Output Ca	pacitance				-	960	1150	pF
	•		t = 1 MHz	= 1 MHZ		85	-	pF
Output Capacitance			V _{DS} = 480 V, V _{GS} = 0 V, f = 1 MHz		-	45	60	pF
					-	110	-	pF
					-	55	70	nC
Gate to Source Gate Charge			$V_{GS} = 10 V$ (Note 4)		-	10.5	13	nC
						28	-	nC
Equivalent	ů		f = 1 MHz			1.7	-	Ω
Characte	ristics		1					1
1					-	42	85	ns
Turn-On Rise Time			$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 16 \text{ A},$ $V_{CS} = 10 \text{ V}, \text{ R}_{C} = 25 \Omega$		-			ns
					-			ns
			(Note 4)		-			ns
					-		16	А
			-	-	48	Α		
					-	-	1.4	V
			$V_{GS} = 0 V, I_{SD} = 16 A,$ $dI_F/dt = 100 A/\mu s$		-	435	-	ns
	ecovery Charge				-	7.0	-	μC
	teristics Drain to Si Breakdown Coefficient Drain-Sou Voltage Zero Gate Gate to Bo teristics Gate Thre Static Drai Forward T haracteri Input Capa Output Ca Reverse T Output Ca Effective O Total Gate Gate to Sc Gate to Dr Equivalent Character Turn-On D Turn-On R Turn-Off D Turn-Off Fa Ce Diode Maximum I Drain to Sc	Parameter teristics Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Drain-Source Avalanche Breakdow Voltage Zero Gate Voltage Drain Current Gate to Body Leakage Current teristics Gate Threshold Voltage Static Drain to Source On Resista Forward Transconductance haracteristics Input Capacitance Output Capacitance Output Capacitance Output Capacitance Output Capacitance Total Gate Charge at 10V Gate to Drain "Miller" Charge Equivalent Series Resistance Characteristics Turn-On Delay Time Turn-Off Delay Time Turn-Off Fall Time Ce Diode Characteristics Maximum Continuous Drain to Source	Parameter teristics Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Drain-Source Avalanche Breakdown Voltage Zero Gate Voltage Drain Current Gate to Body Leakage Current teristics Gate Threshold Voltage Static Drain to Source On Resistance Forward Transconductance haracteristics Input Capacitance Output Capacitance Output Capacitance Output Capacitance Effective Output Capacitance Output Capacitance Gate to Source Gate Charge Gate to Drain "Miller" Charge Equivalent Series Resistance Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Fall Time Ce Diode Characteristics Maximum Continuous Drain to Source Diode Maximum Pulsed Drain to Source Diode For Drain to Source Diode Forward Voltage	teristicsDrain to Source Breakdown Voltage $I_D = 250 \ \mu$ A, $V_{GS} = 0 \ V$, $I_D = 250 \ \mu$ A, $V_{GS} = 0 \ V$, $I_D = 250 \ \mu$ A, $V_{GS} = 0 \ V$, $I_D = 250 \ \mu$ A, ReferenceDrain-Source Avalanche Breakdown Voltage $V_{GS} = 0 \ V$, $I_D = 16 \ A$ Zero Gate Voltage Drain Current $V_{DS} = 600 \ V$, $V_{GS} = 0 \ V$, $V_{DS} = 480 \ V$, $T_C = 1250$ (Gate to Body Leakage CurrentGate Threshold Voltage $V_{GS} = \pm 30 \ V$, $V_{DS} = 0 \ V$ Static Drain to Source On Resistance $V_{GS} = 10 \ V$, $I_D = 8 \ A$ Forward Transconductance $V_{DS} = 40 \ V$, $I_D = 8 \ A$ haracteristicsInput CapacitanceOutput Capacitance $V_{DS} = 480 \ V$, $V_{GS} = 0 \ V$, f = 1 MHzOutput Capacitance $V_{DS} = 480 \ V$, $V_{GS} = 0 \ V$, f Gate to Source Gate ChargeVoltage to Drain "Miller" ChargeF = 1 \ MHzEquivalent Series Resistancef = 1 \ MHzCharacteristicsTurn-On Delay Time Turn-Off Delay TimeTurn-Off Delay Time $V_{DD} = 300 \ V$, $I_D = 16 \ A$, $V_{GS} = 10 \ V$, $G_S = 25 \ \Omega$ Maximum Continuous Drain to Source Diode Forward Current Maximum Pulsed Drain to Source Diode Forward Current Drain to Source Diode Forward Current Drain to Source Diode Forward Current Drain to Source Diode Forward Current	ParameterTest ConditionsteristicsIn the Source Breakdown VoltageDrain to Source Breakdown Voltage Temperature CoefficientID = 250 μ A, VGS = 0 V, TJ = 150°CBreakdown Voltage Temperature CoefficientID = 250 μ A, Referenced to 25°CDrain-Source Avalanche Breakdown VoltageVGS = 0 V, ID = 16 AVageVDS = 600 V, VGS = 0 VZero Gate Voltage Drain CurrentVDS = 480 V, TC = 125°CGate to Body Leakage CurrentVGS = ±30 V, VDS = 0 VteristicsGate Threshold VoltageVGS = 10 V, ID = 8 AForward TransconductanceVDS = 40 V, ID = 8 AharacteristicsInput CapacitanceVDS = 25 V, VGS = 0 V, f = 1 MHzQutput CapacitanceVDS = 25 V, VGS = 0 V, f = 1 MHzOutput CapacitanceVDS = 480 V, VGS = 0 V, f = 1 MHzCharacteristicsVDS = 0 V to 400 V, VGS = 0 V, f = 1 MHzCharacteristicsVDS = 480 V, ID = 16 A, VGS = 10 V, Gate to Drain "Miller" ChargeTurn-On Delay Time Turn-On Rise TimeVDD = 300 V, ID = 16 A, VGS = 10 V, GS = 10 V, RG = 25 \Omega, (Note 4)CharacteristicsVDD = 300 V, ID = 16 A, VGS = 10 V, RG = 25 \Omega, (Note 4)Colode CharacteristicsVDD = 300 V, ID = 16 A, VGS = 10 V, RG = 25 \Omega, (Note 4)Turn-On Bley Time Turn-Off Fall Time(Note 4)Cobiode CharacteristicsVGS = 0 V, VGS = 0 V, VGS = 10 V, VGS = 10 V, RG = 25 \Omega, (Note 4)Turn-Off Collay Time Turn-Off Fall Time(Note Forward Current Maximum Pulsed Drain to Source Diode Forwa	ParameterTest ConditionsMin.teristicsDrain to Source Breakdown Voltage $I_D = 250 \ \mu A, V_{GS} = 0 \ V, T_J = 25^{\circ}C$ 600Breakdown Voltage Temperature Coefficient $I_D = 250 \ \mu A, V_{GS} = 0 \ V, T_J = 150^{\circ}C$ -Drain-Source Avalanche Breakdown Voltage $V_{GS} = 0 \ V, I_D = 16 \ A$ -Zero Gate Voltage Drain Current $V_{DS} = 600 \ V, V_{GS} = 0 \ V$ -Gate to Body Leakage Current $V_{GS} = 480 \ V, T_C = 125^{\circ}C$ -Gate Threshold Voltage $V_{GS} = 10 \ V, I_D = 8 \ A$ -Forward Transconductance $V_{DS} = 40 \ V, I_D = 8 \ A$ -Proved Transconductance $V_{DS} = 25 \ V, V_{GS} = 0 \ V, I_D = 8 \ A$ -Provard Transconductance $V_{DS} = 25 \ V, V_{GS} = 0 \ V, I_D = 8 \ A$ -ParateristicsInput Capacitance Output Capacitance $V_{DS} = 40 \ V, I_D = 8 \ A$ -Output Capacitance Output Capacitance $V_{DS} = 0 \ V, 0_{GS} = 0 \ V, I = 1 \ MHz$ -Effective Output Capacitance Gate to Drain "Miller" Charge $V_{DS} = 10 \ V, 0_{SS} = 0 \ V, I = 1 \ MHz$ -CharacteristicsTurn-On Delay Time Turn-On Bleay TimeV_{DD} = 300 \ V, I_D = 16 \ A, 0 \ V_{GS} = 10 \ V, 0_{GS} = 10 \	$\begin{tabular}{ c c c c c } \hline Parameter Test Conditions Min. Typ. teristics \\ \hline teristics \\ \hline \begin{tabular}{ c c c c c } \hline Test Source Breakdown Voltage Breakdown Voltage Breakdown Voltage Temperature Coefficient Issue Source Avalanche Breakdown Voltage Temperature Coefficient Issue Source Avalanche Breakdown Voltage Issue Source Avalanche Breakdown Voltage VGS = 0 V, I_D = 16 A $	$\begin{tabular}{ c c c c c } \hline Parameter & Test Conditions & Min. Typ. Max. \\ \hline teristics \\ \hline teristics \\ \hline \begin{tabular}{ c c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline teristics \\ \hline \begin{tabular}{ c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c c c } \hline Test Conditions & Min. Typ. Max. \\ \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$



www.fairchildsemi.com

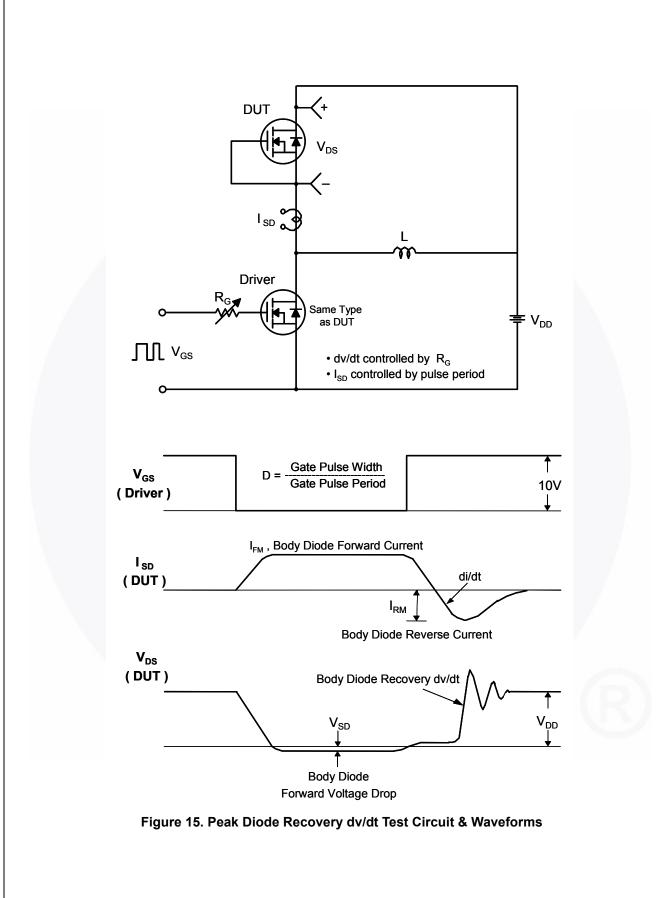


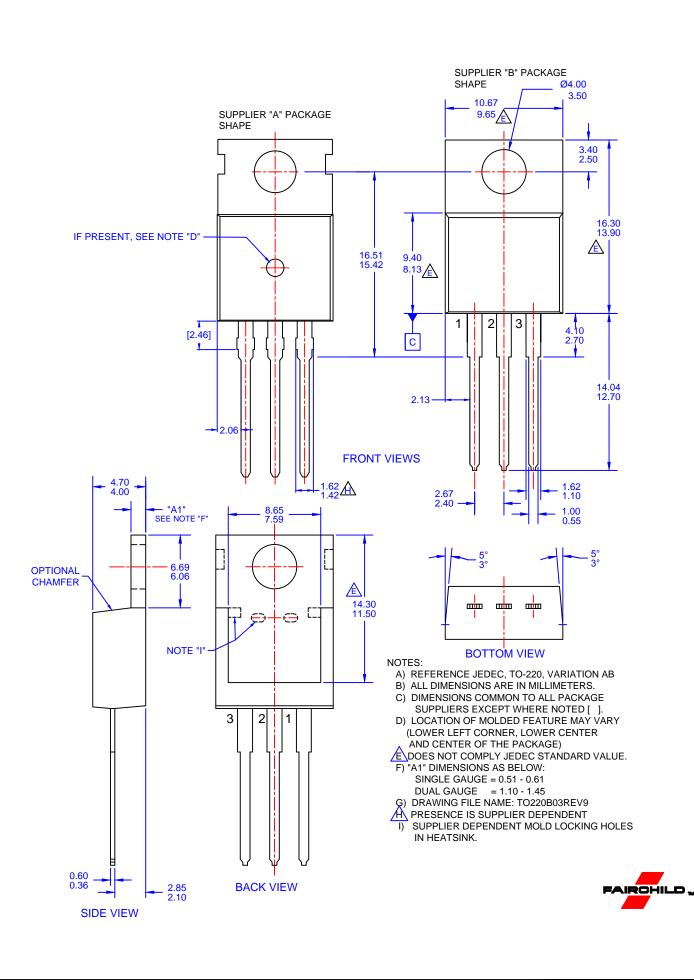


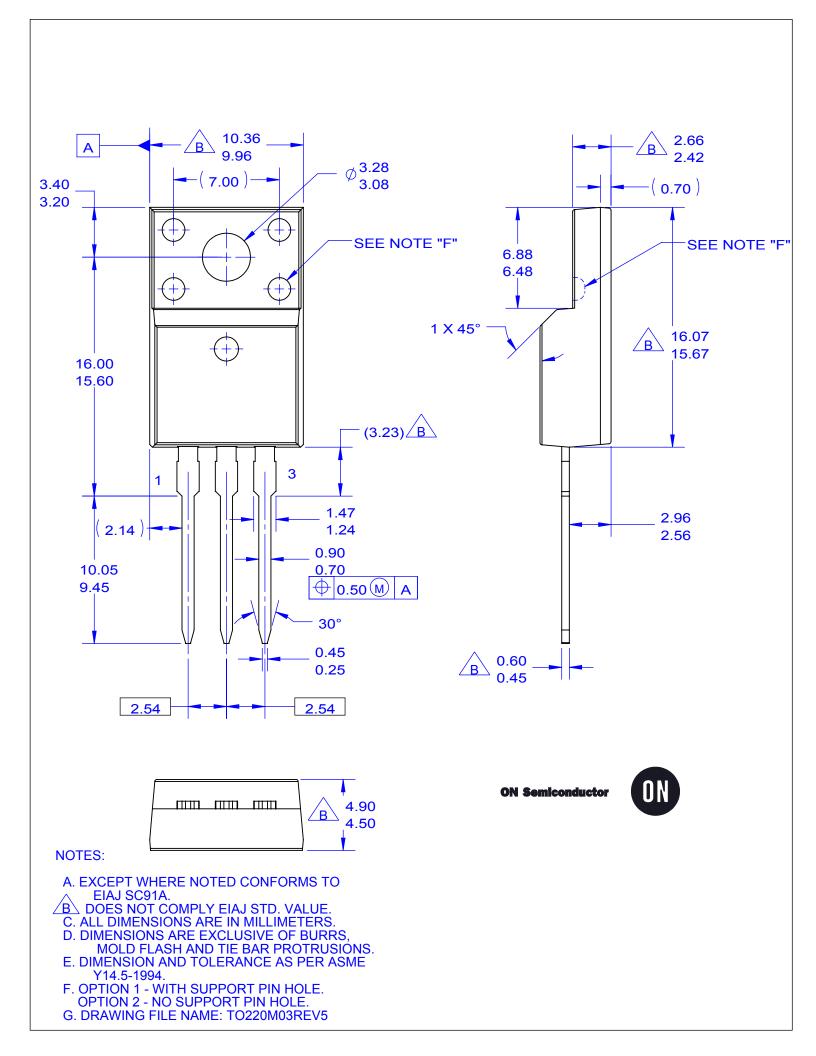


FCP16N60 / FCPF16N60 — N-Channel SuperFET[®] MOSFET

6







ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor has against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death ass

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

© Semiconductor Components Industries, LLC